

## **TEST REPORT**

**Reference No.....**: WTF22F03058122S

Applicant..... : Mid Ocean Brands B.V.

Hong Kong

Manufacturer..... : 107961

Address. .... : /

Product Name.....: RFID blocking card

Model No.....: MO9751

Ratings....:: --

Test specification.....: Customer requirements

Date of Receipt sample.....: 2022-03-30

**Date of Test** : 2022-04-04 to 2022-04-05

Date of Issue ..... : 2022-04-08

Test Report Form No......: WST-133188-02A

Test Result : See the attached sheets

#### Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

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Compiled by:

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Approved by:

Jerry Mu

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List of test items:

No.	Test Items	Requirement + Test	Result
1	Anti-skimming test	Customer requirements	See below
Whet   Yest   Test	contract ther parts of tests for the product have been sub- es	contracted to other labs:	grifte grifte di The grifte grif 4 fe fe
Possi	ble test case verdicts:	COLOR COLOR MODE MADE AND	April April
- test	case does not apply to the test object:	N	State State
- test	object does meet the requirement:	P (Pass)	April 1
- test	object does not meet the requirement	F (Fail)	Let Set 3

# W

#### Test Item:

Anti-skimming test

#### 1.1 Test Environment

Temperature: 23 °C Humidity: 50% RH

### 1.2 Test procedure:

- 1) Keep the IC card and the sample close together. Put the sample gradually close to the reading machine, to see how far the IC card could be read. Mark the distance A
- 2) Then the sample is separated from the IC card. And put this IC card gradually close to the reading machine, to see how far the IC card could be read. Mark the distance B.
- 3) Compare A and B

#### 1.3 Test result:

#### 1.4

Sample	No.	Test position
	В	40.1 mm
1	A	18.3 mm
2	В	40.2 mm
antifer antie	A	18.9 mm
3	В	40.1 mm
	A	18.7 mm
4	В	40.3 mm
4	Α	19.0 mm

#### Remark:

- A Distance of the IC card can be read with sample;
- B Distance of the IC card can be read without sample.
- NG Negative, cannot be read
- 0 can be read when contact the machine





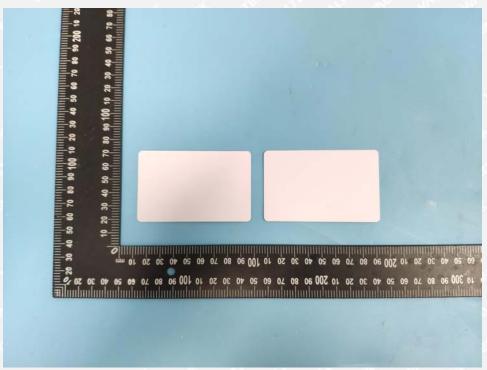


Photo 1 - Sample

===== End of Report =====

